Power Field Effect Transistor DPAK for Surface Mount

N-Channel Enhancement-Mode Silicon Gate

This TMOS Power FET is designed for high speed, low loss power switching applications such as switching regulators, converters, solenoid and relay drivers.

- Silicon Gate for Fast Switching Speeds
- Low $R_{DS(on)}$ 0.3 Ω Max
- Rugged SOA is Power Dissipation Limited
- Source—to—Drain Diode Characterized for Use With Inductive Loads
- Low Drive Requirement $V_{GS(th)} = 4.0 \text{ V Max}$
- Surface Mount Package on 16 mm Tape

MAXIMUM RATINGS

Rating	Symbol	Value	Unit
Drain-Source Voltage	V_{DSS}	150	Vdc
Drain-Gate Voltage (R_{GS} = 1.0 $M\Omega$)	V_{DGR}	150	Vdc
Gate-Source Voltage — Continuous — Non-Repetitive $(t_p \le 50~\mu s)$	$V_{GS} \ V_{GSM}$	± 20 ± 40	Vdc Vpk
Drain Current — Continuous — Pulsed	I _D I _{DM}	6.0 20	Adc
Total Power Dissipation @ T _C = 25°C Derate above 25°C	P _D	20 0.16	Watts W/°C
Total Power Dissipation @ T _A = 25°C Derate above 25°C (Note 1)	P_{D}	1.25 0.01	Watts W/°C
Total Power Dissipation @ T _A = 25°C (1) Derate above 25°C (Note 2)	P_{D}	1.75 0.014	Watts W/°C
Operating and Storage Junction Temperature Range	T _J , T _{stg}	-65 to +150	°C

THERMAL CHARACTERISTICS

Characteristic	Symbol	Value	Unit
Thermal Resistance - Junction to Case - Junction to Ambient (Note 1) - Junction to Ambient (Note 2)	R _{θJC} R _{θJA} R _{θJA}	6.25 100 71.4	°C/W

- When surface mounted to an FR4 board using the minimum recommended pad size.
- 2. When surface mounted to an FR4 board using 0.5 sq. in. drain pad size.

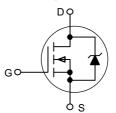


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V _{(BR)DSS}	R _{DS(on)} MAX	I _D MAX
150 V	0.3 Ω	6.0 A

N-CHANNEL





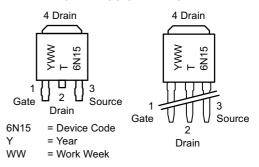


CASE 369C DPAK (Surface Mount) STYLE 2



CASE 369D DPAK (Straight Lead) STYLE 2

MARKING DIAGRAM & PIN ASSIGNMENTS



ORDERING INFORMATION

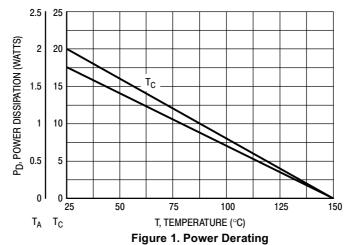
Device	Package	Shipping [†]
MTD6N15	DPAK	75 Units/Rail
MTD6N15-1	DPAK Straight Lead	75 Units/Rail
MTD6N15T4	DPAK	2500 Tape & Reel

†For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specification Brochure, BRD8011/D.

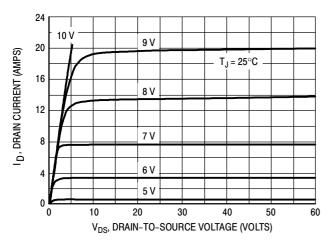
ELECTRICAL CHARACTERISTICS ($T_J = 25^{\circ}C$ unless otherwise noted)

Ch	Symbol	Min	Max	Unit	
OFF CHARACTERISTICS		•			
Drain-Source Breakdown Voltage $(V_{GS} = 0 \text{ Vdc}, I_D = 0.25 \text{ mAdc})$	V _{(BR)DSS}	150	_	Vdc	
Zero Gate Voltage Drain Current (V_{DS} = Rated V_{DSS} , V_{GS} = 0 Vdc) T_J = 125°C	I _{DSS}	_ _	10 100	μAdc	
Gate-Body Leakage Current, Forwar	d (V _{GSF} = 20 Vdc, V _{DS} = 0)	I _{GSSF}	1 –	100	nAdc
Gate-Body Leakage Current, Revers	e (V _{GSR} = 20 Vdc, V _{DS} = 0)	I _{GSSR}	_	100	nAdc
ON CHARACTERISTICS (Note 3)					
Gate Threshold Voltage ($V_{DS} = V_{GS}$, $T_J = 100$ °C	I _D = 1.0 mAdc)	V _{GS(th)}	2.0 1.5	4.5 4.0	Vdc
Static Drain-Source On-Resistance	(V _{GS} = 10 Vdc, I _D = 3.0 Adc)	R _{DS(on)}	1 –	0.3	Ohm
Drain-Source On-Voltage (V_{GS} = 10 (I_D = 6.0 Adc) (I_D = 3.0 Adc, T_J = 100°C)	V _{DS(on)}	_ _	1.8 1.5	Vdc	
Forward Transconductance (V _{DS} = 1	5 Vdc, I _D = 3.0 Adc)	9FS	2.5	_	mhos
DYNAMIC CHARACTERISTICS					
Input Capacitance	(V _{DS} = 25 Vdc, V _{GS} = 0 Vdc,	C _{iss}	_	1200	pF
Output Capacitance	f = 1.0 MHz)	C _{oss}	_	500	1
Reverse Transfer Capacitance	See Figure 11	C _{rss}	_	120	
SWITCHING CHARACTERISTICS* (T	_J = 100°C)				
Turn-On Delay Time		t _{d(on)}	_	50	ns
Rise Time	$(V_{DD} = 25 \text{ Vdc}, I_D = 3.0 \text{ Adc},$	t _r	_	180	
Turn-Off Delay Time	- $R_G = 50 \Omega$) See Figures 13 and 14	t _{d(off)}	_	200	1
Fall Time	<u> </u>	t _f	_	100	1
Total Gate Charge	(V _{DS} = 0.8 Rated V _{DSS} ,	Qg	15 (Typ)	30	nC
Gate-Source Charge	I _D = Rated I _D , V _{GS} = 10 Vdc)	Q _{gs}	8.0 (Typ)	_	1
Gate-Drain Charge	See Figure 12	Q _{gd}	7.0 (Typ)		
SOURCE-DRAIN DIODE CHARACTE	RISTICS*				
Forward On-Voltage		V_{SD}	1.3 (Typ)	2.0	Vdc
Forward Turn-On Time	$(I_S = 6.0 \text{ Adc, di/dt} = 25 \text{ A/}\mu\text{s}$ $V_{GS} = 0 \text{ Vdc,})$	t _{on}	Limited by stray inductanc		uctance
Reverse Recovery Time] • • • • • • • • • • • • • • • • • • •	t _{rr}	325 (Typ)	_	ns

3. Pulse Test: Pulse Width ≤ 300 μs, Duty Cycle ≤ 2%.



TYPICAL ELECTRICAL CHARACTERISTICS



3.2 V_{DS} = V_{GS} V_{DS} = 1 mA

2.8 V_{DS} = 1 mA

2.4 V_{DS} = 1 mA

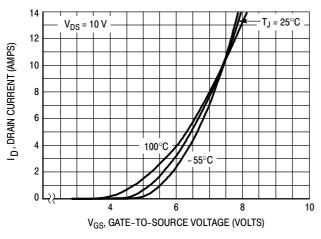
2.4 V_{DS} = 1 mA

2.4 V_{DS} = 1 mA

3.2 V_{DS} = 1 mA

Figure 2. On-Region Characteristics

Figure 3. Gate-Threshold Voltage Variation With Temperature



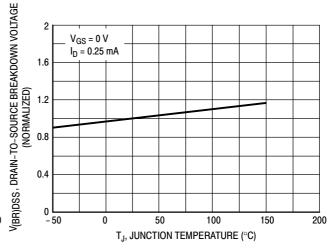
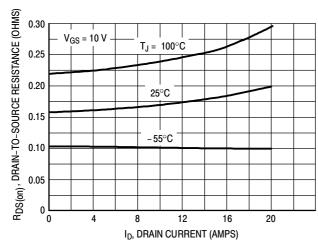


Figure 4. Transfer Characteristics

Figure 5. Breakdown Voltage Variation With Temperature



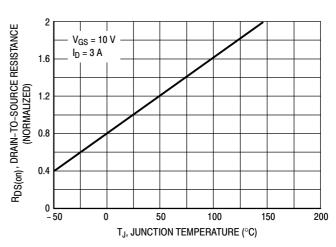


Figure 6. On-Resistance versus Drain Current

Figure 7. On-Resistance Variation With Temperature

SAFE OPERATING AREA

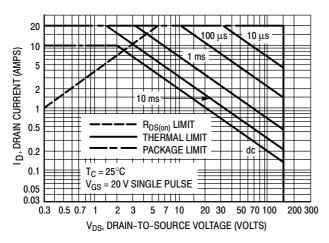


Figure 8. Maximum Rated Forward Biased Safe Operating Area

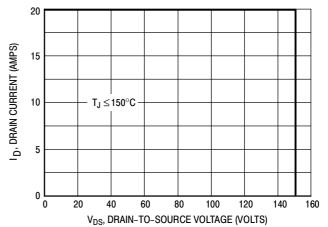


Figure 9. Maximum Rated Switching Safe Operating Area

FORWARD BIASED SAFE OPERATING AREA

The FBSOA curves define the maximum drain-to-source voltage and drain current that a device can safely handle when it is forward biased, or when it is on, or being turned on. Because these curves include the limitations of simultaneous high voltage and high current, up to the rating of the device, they are especially useful to designers of linear systems. The curves are based on a case temperature of 25°C and a maximum junction temperature of 150°C. Limitations for repetitive pulses at various case temperatures can be determined by using the thermal response curves. Motorola "Transient AN569, Application Note, Thermal Resistance-General Data and Its Use" provides detailed instructions.

SWITCHING SAFE OPERATING AREA

The switching safe operating area (SOA) of Figure 9 is the boundary that the load line may traverse without incurring damage to the MOSFET. The fundamental limits are the peak current, I_{DM} and the breakdown voltage, $V_{(BR)DSS}$. The switching SOA shown in Figure 8 is applicable for both turn—on and turn—off of the devices for switching times less than one microsecond.

The power averaged over a complete switching cycle must be less than:

$$T_{J(max)} - T_{C}$$
 $R_{\theta JC}$

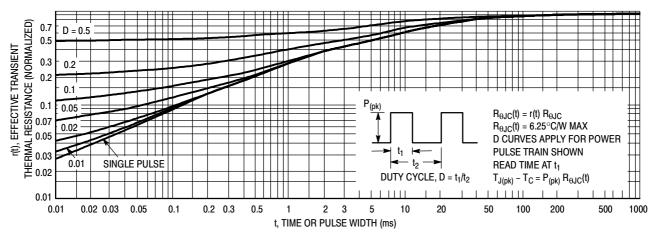
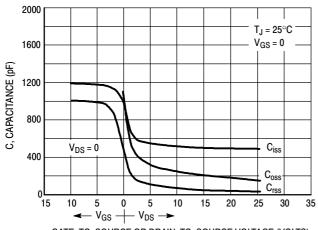


Figure 10. Thermal Response



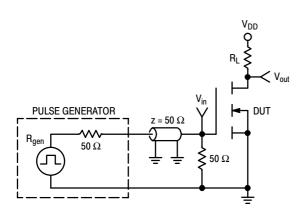
16 T_J = 25°C I_D = 6 A V_{DS} = 50 V 12 V_{DS} = 50 V Q_g, TOTAL GATE CHARGE (nC)

GATE-TO-SOURCE OR DRAIN-TO-SOURCE VOLTAGE (VOLTS)

Figure 11. Capacitance Variation

Figure 12. Gate Charge versus Gate-To-Source Voltage

RESISTIVE SWITCHING



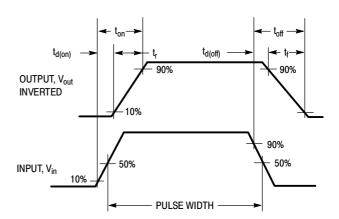
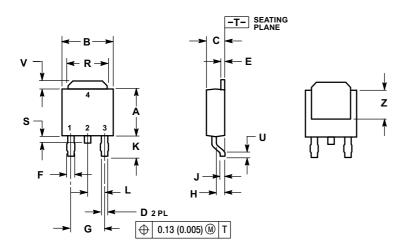


Figure 13. Switching Test Circuit

Figure 14. Switching Waveforms

PACKAGE DIMENSIONS

DPAK CASE 369C-01 ISSUE O

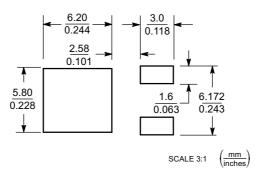


- NOTES: 1. DIMENSIONING AND TOLERANCING PER ANSI Y14.5M, 1982. 2. CONTROLLING DIMENSION: INCH.

	INCHES		MILLIM	ETERS
DIM	MIN	MAX	MIN	MAX
Α	0.235	0.245	5.97	6.22
В	0.250	0.265	6.35	6.73
С	0.086	0.094	2.19	2.38
D	0.027	0.035	0.69	0.88
E	0.018	0.023	0.46	0.58
F	0.037	0.045	0.94	1.14
G	0.180	BSC	4.58 BSC	
Н	0.034	0.040	0.87	1.01
J	0.018	0.023	0.46	0.58
K	0.102	0.114	2.60	2.89
L	0.090 BSC		2.29 BSC	
R	0.180	0.215	4.57	5.45
S	0.025	0.040	0.63	1.01
U	0.020		0.51	-
V	0.035	0.050	0.89	1.27
Z	0.155		3.93	

- STYLE 2: PIN 1. GATE 2. DRAIN 3. SOURCE 4. DRAIN

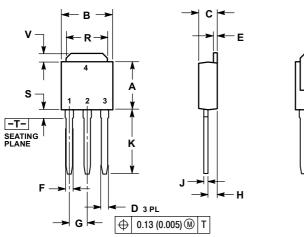
SOLDERING FOOTPRINT*

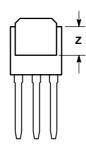


^{*}For additional information on our Pb-Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

PACKAGE DIMENSIONS

DPAK CASE 369D-01 ISSUE O





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	INC	INCHES MILLIMETER		IETERS
DIM	MIN	MAX	MIN	MAX
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В	0.250	0.265	6.35	6.73
С	0.086	0.094	2.19	2.38
D	0.027	0.035	0.69	0.88
Е	0.018	0.023	0.46	0.58
F	0.037	0.045	0.94	1.14
G	0.090 BSC		2.29 BSC	
Н	0.034	0.040	0.87	1.01
J	0.018	0.023	0.46	0.58
K	0.350	0.380	8.89	9.65
R	0.180	0.215	4.45	5.45
S	0.025	0.040	0.63	1.01
٧	0.035	0.050	0.89	1.27
Z	0.155		3.93	

- STYLE 2: PIN 1. GATE 2. DRAIN 3. SOURCE 4. DRAIN

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